The LTC®3863 is a robust, inverting DC/DC PMOS controller optimized for automotive and industrial applications. It drives a P-channel power MOSFET to generate a negative output and requires just a single inductor to complete the circuit. Output voltages from –0.4V to –150V are typically achievable with higher voltages possible, only limited by external components.

The LTC3863 offers excellent light load efficiency, drawing only 70μA quiescent current in a user programmable Burst Mode operation. Its peak current mode, constant frequency PWM architecture provides for good control of switching frequency and output current limit. The switching frequency can be programmed from 50kHz to 850kHz with an external resistor and can be synchronized to an external clock from 75kHz to 750kHz.

The LTC3863 offers programmable soft-start or output tracking. Safety features include overvoltage, overcurrent and short-circuit protection including frequency foldback.

The LTC3863 is available in thermally enhanced 12-lead Thermally Enhanced MSOP and DFN packages.

All registered trademarks and trademarks are the property of their respective owners. Protected by U.S. patents, including 5731694.
**LTC3863**

**ABSOLUTE MAXIMUM RATINGS** (Note 1)

- Input Supply Voltage ($V_{IN}$) ................. $-0.3V$ to $65V$
- $V_{IN}$-$V_{SENSE}$ Voltage ......................... $-0.3V$ to $6V$
- $V_{IN}$-$V_{CAP}$ Voltage ........................... $-0.3V$ to $10V$
- RUN Voltage ........................................ $-0.3V$ to $65V$
- $V_{FBN}$, PLLIN/MODE Voltages ................. $-0.3V$ to $6V$
- SS, ITH, FREQ, $V_{FB}$ Voltages ..................... $-0.3V$ to $5V$

Operating Junction Temperature Range (Notes 2, 3, 4)

- LTC3863E,I ............................................. $-40°C$ to $125°C$
- LTC3863H .............................................. $-40°C$ to $150°C$
- LTC3863MP ............................................ $-55°C$ to $150°C$

Storage Temperature Range .................. $-65°C$ to $150°C$

Lead Temperature (Soldering, 10 sec)

MSOP Package .......................... $300°C$

**PIN CONFIGURATION**

**ORDER INFORMATION**

<table>
<thead>
<tr>
<th>LEAD FREE FINISH</th>
<th>TAPE AND REEL</th>
<th>PART MARKING*</th>
<th>PACKAGE DESCRIPTION</th>
<th>TEMPERATURE RANGE</th>
</tr>
</thead>
<tbody>
<tr>
<td>LTC3863EMSE#PBF</td>
<td>LTC3863EMSE#TRPBF</td>
<td>3863</td>
<td>12-Lead Plastic MSOP</td>
<td>$-40°C$ to $125°C$</td>
</tr>
<tr>
<td>LTC3863IMSE#PBF</td>
<td>LTC3863IMSE#TRPBF</td>
<td>3863</td>
<td>12-Lead Plastic MSOP</td>
<td>$-40°C$ to $125°C$</td>
</tr>
<tr>
<td>LTC3863HMSE#PBF</td>
<td>LTC3863HMSE#TRPBF</td>
<td>3863</td>
<td>12-Lead Plastic MSOP</td>
<td>$-40°C$ to $150°C$</td>
</tr>
<tr>
<td>LTC3863MPMSE#PBF</td>
<td>LTC3863MPMSE#TRPBF</td>
<td>3863</td>
<td>12-Lead Plastic MSOP</td>
<td>$-55°C$ to $150°C$</td>
</tr>
<tr>
<td>LTC3863EDE#PBF</td>
<td>LTC3863EDE#TRPBF</td>
<td>3863</td>
<td>12-Lead (4mm × 3mm) Plastic DFN</td>
<td>$-40°C$ to $125°C$</td>
</tr>
<tr>
<td>LTC3863IDE#PBF</td>
<td>LTC3863IDE#TRPBF</td>
<td>3863</td>
<td>12-Lead (4mm × 3mm) Plastic DFN</td>
<td>$-40°C$ to $125°C$</td>
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<tr>
<td>LTC3863HDE#PBF</td>
<td>LTC3863HDE#TRPBF</td>
<td>3863</td>
<td>12-Lead (4mm × 3mm) Plastic DFN</td>
<td>$-40°C$ to $150°C$</td>
</tr>
<tr>
<td>LTC3863MPDE#PBF</td>
<td>LTC3863MPDE#TRPBF</td>
<td>3863</td>
<td>12-Lead (4mm × 3mm) Plastic DFN</td>
<td>$-55°C$ to $150°C$</td>
</tr>
</tbody>
</table>

Contact the factory for parts specified with wider operating temperature ranges. *The temperature grade is identified by a label on the shipping container.

Tape and reel specifications. Some packages are available in 500 unit reels through designated sales channels with #TRMPBF suffix.
# Electrical Characteristics

The ● denotes the specifications which apply over the specified operating junction temperature range, otherwise specifications are at $T_A = 25^\circ$C. (Note 4) $V_{IN} = 12$V, unless otherwise noted.

## Input Supply

<table>
<thead>
<tr>
<th>SYMBOL</th>
<th>PARAMETER</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{IN}$</td>
<td>Input Voltage Operating Range</td>
<td></td>
<td>3.5</td>
<td>60</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$V_{UVLO}$</td>
<td>Undervoltage Lockout $(V_{IN}-V_{CAP})$ Ramping Up Threshold $(V_{IN}-V_{CAP})$ Ramping Down Threshold Hysteresis</td>
<td>●</td>
<td>3.25</td>
<td>3.50</td>
<td>3.8</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td>●</td>
<td>3.00</td>
<td>3.25</td>
<td>3.50</td>
<td>V</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>0.25</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$I_{Q}$</td>
<td>Input DC Supply Current</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>Pulse-Skipping Mode PLLIN/MODE = 0V, FREQ = 0V, $V_{FB} = 0.83$V (No Load)</td>
<td></td>
<td>0.77</td>
<td></td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td></td>
<td>Burst Mode Operation PLLIN/MODE = Open, FREQ = 0V, $V_{FB} = 0.83$V (No Load)</td>
<td></td>
<td>50</td>
<td></td>
<td></td>
<td>µA</td>
</tr>
</tbody>
</table>

## Output Sensing

<table>
<thead>
<tr>
<th>SYMBOL</th>
<th>PARAMETER</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{REG}$</td>
<td>Regulated Feedback Voltage $V_{REG} = (V_{FB} - V_{FBN})$ $V_{ITH} = 1.2$V (Note 5)</td>
<td>●</td>
<td>0.791</td>
<td>0.800</td>
<td>0.809</td>
<td>V</td>
</tr>
<tr>
<td>$\Delta V_{REG}$</td>
<td>Feedback Voltage Line Regulation $V_{IN} = 3.8$V to 60V (Note 5)</td>
<td></td>
<td>-0.005</td>
<td>0.005</td>
<td></td>
<td>%/V</td>
</tr>
<tr>
<td>$\Delta V_{IN}$</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$\Delta V_{ITH}$</td>
<td>Feedback Voltage Load Regulation $V_{ITH} = 0.6$V to 1.8V (Note 5)</td>
<td></td>
<td>-0.1</td>
<td>-0.015</td>
<td>0.1</td>
<td>%</td>
</tr>
<tr>
<td>$g_{m(EA)}$</td>
<td>Error Amplifier Transconductance $V_{ITH} = 1.2$V, $\Delta I_{ITH} = \pm 5$µA (Note 5)</td>
<td></td>
<td>1.8</td>
<td></td>
<td></td>
<td>mS</td>
</tr>
<tr>
<td>$I_{FBN}$</td>
<td>Feedback Negative Input Bias Current</td>
<td></td>
<td>-50</td>
<td>-10</td>
<td>50</td>
<td>µA</td>
</tr>
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</table>

## Current Sensing

<table>
<thead>
<tr>
<th>SYMBOL</th>
<th>PARAMETER</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{ILIM}$</td>
<td>Current Limit Threshold $(V_{IN}-V_{SENSE})$ $V_{FB} = 0.77$V</td>
<td>●</td>
<td>85</td>
<td>95</td>
<td>103</td>
<td>mV</td>
</tr>
<tr>
<td>$I_{SENSE}$</td>
<td>SENSE Pin Input Current $V_{SENSE} = V_{IN}$</td>
<td></td>
<td>0.1</td>
<td>2</td>
<td></td>
<td>µA</td>
</tr>
</tbody>
</table>

## Start-Up and Shutdown

<table>
<thead>
<tr>
<th>SYMBOL</th>
<th>PARAMETER</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{RUN}$</td>
<td>RUN Pin Enable Threshold $V_{RUN}$ Rising</td>
<td>●</td>
<td>1.22</td>
<td>1.26</td>
<td>1.32</td>
<td>V</td>
</tr>
<tr>
<td>$V_{RUNHYS}$</td>
<td>RUN Pin Hysteresis</td>
<td></td>
<td>150</td>
<td></td>
<td></td>
<td>µV</td>
</tr>
<tr>
<td>$I_{SS}$</td>
<td>Soft-Start Pin Charging Current $V_{SS} = 0$V</td>
<td></td>
<td>10</td>
<td></td>
<td></td>
<td>µA</td>
</tr>
</tbody>
</table>

## Switching Frequency and Clock Synchronization

<table>
<thead>
<tr>
<th>SYMBOL</th>
<th>PARAMETER</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>$f$</td>
<td>Programmable Switching Frequency $R_{FREQ} = 24.9k\Omega$ $R_{FREQ} = 64.9k\Omega$ $R_{FREQ} = 105k\Omega$</td>
<td></td>
<td>375</td>
<td>440</td>
<td>505</td>
<td>kHz</td>
</tr>
<tr>
<td></td>
<td></td>
<td></td>
<td>810</td>
<td></td>
<td></td>
<td>kHz</td>
</tr>
<tr>
<td>$f_{LO}$</td>
<td>Low Switching Frequency FREQ = 0V</td>
<td></td>
<td>320</td>
<td>350</td>
<td>380</td>
<td>kHz</td>
</tr>
<tr>
<td>$f_{HI}$</td>
<td>High Switching Frequency FREQ = Open</td>
<td></td>
<td>485</td>
<td>535</td>
<td>585</td>
<td>kHz</td>
</tr>
<tr>
<td>$f_{SYNC}$</td>
<td>Synchronization Frequency</td>
<td></td>
<td>75</td>
<td>750</td>
<td></td>
<td>kHz</td>
</tr>
<tr>
<td>$V_{CLK(H)}$</td>
<td>Clock Input High Level into PLLIN/MODE</td>
<td>●</td>
<td>2</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$V_{CLK(LO)}$</td>
<td>Clock Input Low Level into PLLIN/MODE</td>
<td>●</td>
<td>0.5</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>$f_{FOLD}$</td>
<td>Foldback Frequency as Percentage of Programmable Frequency $V_{FB} = 0$V, FREQ = 0V</td>
<td></td>
<td>18</td>
<td></td>
<td></td>
<td>%</td>
</tr>
<tr>
<td>$t_{ON(MIN)}$</td>
<td>Minimum On-Time</td>
<td></td>
<td>220</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
</tbody>
</table>

For more information [www.analog.com](http://www.analog.com)
### Electrical Characteristics

The ● denotes the specifications which apply over the specified operating junction temperature range, otherwise specifications are at $T_A = 25^\circ C$. (Note 4) $V_{IN} = 12V$, unless otherwise noted.

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<tr>
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<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{CAP}$</td>
<td>Gate Bias LDO Output Voltage ($V_{IN}-V_{CAP}$)</td>
<td>$I_{GATE} = 0mA$</td>
<td>●</td>
<td>7.6</td>
<td>8.0</td>
<td>8.5</td>
</tr>
<tr>
<td>$V_{CAPDROP}$</td>
<td>Gate Bias LDO Dropout Voltage</td>
<td>$V_{IN} = 5V$, $I_{GATE} = 15mA$</td>
<td></td>
<td>0.2</td>
<td>0.5</td>
<td></td>
</tr>
<tr>
<td>$\Delta V_{CAP\text{(LINE)}}$</td>
<td>Gate Bias LDO Line Regulation</td>
<td>$9V \leq V_{IN} \leq 60V$, $I_{GATE} = 0mA$</td>
<td></td>
<td>0.002</td>
<td>0.03</td>
<td></td>
</tr>
<tr>
<td>$\Delta V_{CAP\text{(LOAD)}}$</td>
<td>Gate Bias LDO Load Regulation</td>
<td>Load = 0mA to 20mA</td>
<td></td>
<td>–3.5</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$R_{UP}$</td>
<td>Gate Pull-Up Resistance</td>
<td>Gate High</td>
<td></td>
<td>2</td>
<td></td>
<td></td>
</tr>
<tr>
<td>$R_{DN}$</td>
<td>Gate Pull-Down Resistance</td>
<td>Gate Low</td>
<td></td>
<td>0.9</td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

### Overvoltage

<table>
<thead>
<tr>
<th>SYMBOL</th>
<th>PARAMETER</th>
<th>CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNITS</th>
</tr>
</thead>
<tbody>
<tr>
<td>$V_{FB\text{OV}}$</td>
<td>$V_{FB}$ Overvoltage Lockout Threshold</td>
<td>GATE Going High without Delay, $V_{FB\text{OV}}-V_{FB\text{NOM}}$ in Percent</td>
<td></td>
<td>10</td>
<td></td>
<td>%</td>
</tr>
</tbody>
</table>

**Note 1:** Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

**Note 2:** Continuous operation above the specified maximum operating junction temperature may impair device reliability or permanently damage the device.

**Note 3:** The junction temperature ($T_J$ in °C) is calculated from the ambient temperature ($T_A$ in °C) and power dissipation ($P_D$ in Watts) as follows:

$$T_J = T_A + (P_D \times \theta_JA)$$

where $\theta_JA$ (in °C/W) is the package thermal impedance provided in the Pin Configuration section for the corresponding package.

**Note 4:** The LTC3863 is tested under pulsed load conditions such that $T_J = T_A$. The LTC3863E is guaranteed to meet performance specifications from 0°C to 85°C operating junction temperature range. The LTC3863E specifications over the –40°C to 125°C operating junction temperature range are assured by design, characterization and correlation with statistical process controls. The LTC3863I is tested in a feedback loop that adjust $V_{REG}$ or $(V_{FB} – V_{FB\text{NOM}})$ to achieve a specified error amplifier output voltage (on ITH pin).
TYPICAL PERFORMANCE CHARACTERISTICS

\( T_A = 25^\circ C, \) unless otherwise noted.

**Pulse-Skipping Mode Operation Waveforms**

- \( V_{IN} = 12V \)
- \( V_{OUT} = -5V \)
- \( I_{LOAD} = 100mA \)
- FIGURE 7 CIRCUIT

**Burst Mode Operation Waveforms**

- \( V_{IN} = 12V \)
- \( V_{OUT} = -5V \)
- \( I_{LOAD} = 100mA \)
- FIGURE 7 CIRCUIT

**Transient Response: Burst Mode Operation**

- \( V_{IN} = 12V \)
- \( V_{OUT} = -5V \)
- \( TRANSIENT = 100mA \) TO 1.6A
- FIGURE 7 CIRCUIT

**Transient Response: Falling Edge Pulse-Skipping Mode Operation**

- \( V_{IN} = 12V \)
- \( V_{OUT} = -5V \)
- \( I_{LOAD} = 1A/DIV \)
- FIGURE 7 CIRCUIT

**Normal Soft-Start**

- \( V_{IN} = 12V \)
- \( V_{OUT} = -5V \)
- \( I_{LOAD} = 1A/DIV \)
- FIGURE 7 CIRCUIT

**Soft-Start into a Prebiased Output**

- \( V_{IN} = 12V \)
- \( V_{OUT} = -5V \)
- \( PRE-BIAS1 = 2V, PRE-BIAS2 = -2V \)
- \( I_{LOAD} = 1A/DIV \)
- FIGURE 11 CIRCUIT

**Output Tracking**

- \( V_{IN} = 12V \)
- \( V_{OUT1} = 5V \)
- \( V_{OUT2} = -5V \)
- \( I_{LOAD1} = I_{LOAD2} = 100mA \)
- FIGURE 11 CIRCUIT
TYPICAL PERFORMANCE CHARACTERISTICS  \( T_A = 25^\circ C \), unless otherwise noted.
TYPICAL PERFORMANCE CHARACTERISTICS

For more information www.analog.com
PIN FUNCTIONS

PLLIN/MODE (Pin 1): External Reference Clock Input and Burst Mode Enable/Disable. When an external clock is applied to this pin, the internal phase-locked loop will synchronize the turn-on edge of the gate drive signal with the rising edge of the external clock. When no external clock is applied, this input determines the operation during light loading. Floating this pin selects low IQ (50µA) Burst Mode operation. Pulling to ground selects pulse-skipping mode operation.

FREQ (Pin 2): Switching Frequency Setpoint Input. The switching frequency is programmed by an external setpoint resistor $R_{FREQ}$ connected between the FREQ pin and signal ground. An internal 20µA current source creates a voltage across the external setpoint resistor to set the internal oscillator frequency. Alternatively, this pin can be driven directly by a DC voltage to set the oscillator frequency. Grounding selects a fixed operating frequency of 350kHz. Floating selects a fixed operating frequency of 535kHz.

SGND (Pin 3): Ground Reference for Small-Signal Analog Component (Signal Ground). Signal ground should be used as the common ground for all small-signal analog inputs and compensation components. Connect the signal ground to the power ground (ground reference for power components) only at one point using a single PCB trace.

SS (Pin 4): Soft-Start and External Tracking Input. The LTC3863 regulates the feedback voltage to the smaller of 0.8V or the voltage on the SS pin. An internal 10µA pull-up current source is connected to this pin. A capacitor to ground at this pin sets the ramp time to the final regulated output voltage. Alternatively, another voltage supply connected through a resistor divider to this pin allows the output to track the other supply during start-up.

VFB (Pin 5): Output Feedback Sense. A sense resistor, $R_{SENSE}$, from the VIN pin to the SENSE pin sets the maximum current limit. The peak inductor current limit is equal to 95mV/$R_{SENSE}$. For accuracy, it is important that the VIN pin and the SENSE pin route directly to the current sense resistor and make a Kelvin (4-wire) connection.

VIN (Pin 11): Chip Power Supply. A minimum bypass capacitor of 0.1µF is required from the VIN pin to power ground. For best performance use a low ESR ceramic capacitor placed near the VIN pin.

ITH (Pin 6): Current Control Threshold and Controller Compensation Point. This pin is the output of the error amplifier and the switching regulator’s compensation point. The voltage ranges from 0V to 2.9V, with 0.8V corresponding to zero sense voltage (zero current). $R_{ITH}$ should never be less than 10K to avoid large signal compensation issues. For further detail please see the section Large Signal Effects on ITH.

VFBN (Pin 7): Feedback Input for an Inverting PWM Controller. Connect $V_{FBN}$ to the center of a resistor divider between the output and $V_{FB}$. The resistor divider is comprised of $R_{FB1}$, placed from the VOUT pin to $V_{FBN}$ pin and $R_{FB2}$, placed from the $V_{FBN}$ pin to $V_{FB}$. It is recommended to set $R_{FB2}$ to be greater than 8K, please see the Output Voltage Programming section for further detail. The $V_{FBN}$ threshold is 0V. To defeat the inverting amplifier and use the LTC3863 as an LTC3864 (noninverting buck), tie $V_{FBN} > 2V$.

RUN (Pin 8): Digital Run Control Input. A RUN voltage above the 1.26V threshold enables normal operation, while a voltage below the threshold shuts down the controller. An internal 0.4µA current source pulls the RUN pin up to about 3.3V. The RUN pin can be connected to an external power supply up to 60V.

CAP (Pin 9): Gate Driver (–) Supply. A low ESR ceramic bypass capacitor of at least 0.1µF or 10X the effective $C_{MILLER}$ of the P-channel power MOSFET, is required from VIN to this pin to serve as a bypass capacitor for the internal regulator. To ensure stable low noise operation, the bypass capacitor should be placed adjacent to the VIN and CAP pins and connected using the same PCB metal layer.

SENSE (Pin 10): Current Sense Input. A sense resistor, $R_{SENSE}$, from the VIN pin to the SENSE pin sets the maximum current limit. The peak inductor current limit is equal to 95mV/$R_{SENSE}$. For accuracy, it is important that the VIN pin and the SENSE pin route directly to the current sense resistor and make a Kelvin (4-wire) connection.

For more information www.analog.com
**PIN FUNCTIONS**

**GATE (Pin 12):** Gate Drive Output for External P-Channel MOSFET. The gate driver bias supply voltage \((V_{IN} - V_{CAP})\) is regulated to 8V when \(V_{IN}\) is greater than 8V. The gate driver is disabled when \((V_{IN} - V_{CAP})\) is less than 3.5V (typical), 3.8V maximum in start-up and 3.25V (typical) 3.5V maximum in normal operation.

**PGND (Exposed Pad Pin 13):** Ground Reference for Power Components (Power Ground). The PGND exposed pad must be soldered to the circuit board for electrical contact and for rated thermal performance of the package. Connect signal ground to power ground only at one point using a single PCB trace.

---

**FUNCTIONAL DIAGRAM**

![Functional Diagram of LTC3863](image-url)
OPERATION

LTC3863 Main Control Loop

The LTC3863 is a nonsynchronous inverting PMOS controller, where an inverting amplifier is used to sense the negative output voltage below ground. The LTC3863 uses a peak current mode control architecture to regulate the output. A feedback resistor, \( R_{FB1} \), is placed between \( V_{OUT} \) and \( V_{FBN} \) and a second resistor, \( R_{FB2} \), is placed between \( V_{FBN} \) and \( V_{FB} \). The LTC3863 has a trimmed internal reference, \( V_{REF} \), that is equal to \( (V_{FB} - V_{FBN}) \). The output voltage is equal to \(-\left(\frac{R_{FB1}}{R_{FB2}}\right) \cdot V_{REF}\) where \( V_{REF} \) is equal to 800mV in normal regulation.

The LTC3863 can also be configured as a noninverting step-down buck regulator when the \( V_{FBN} \) node is pulled greater than 2V but held less than 5V, which disables the internal inverting amplifier. A feedback resistor, \( R_{FB1} \), is placed between \( V_{OUT} \) and \( V_{FB} \) and a second resistor, \( R_{FB2} \), is placed between \( V_{FB} \) and \( SGND \). In the noninverting buck mode the \( V_{FB} \) input is compared to the internal reference, \( V_{REF} \), by a transconductance error amplifier (EA). The internal reference can be either a fixed 0.8V reference, \( V_{REF} \), or the voltage input on the SS pin. In normal operation \( V_{FB} \) regulates to the internal 0.8V reference voltage. The output voltage in normal regulation is equal to \((R_{FB1} + R_{FB2})/R_{FB2} \cdot 800\text{mV} \).

In soft-start or tracking mode when the SS pin voltage is less than the internal 0.8V reference voltage, \( V_{FB} \) will regulate to the SS pin voltage. The error amplifier output connects to the ITH (current \( I \) threshold \( TH \)) pin. The voltage level on the ITH pin is then summed with a slope compensation ramp to create the peak inductor current setpoint.

The peak inductor current is measured through a sense resistor, \( R_{SENSE} \), placed across the \( V_{IN} \) and SENSE pins.

The resultant differential voltage from \( V_{IN} \) to SENSE is proportional to the inductor current and is compared to the peak inductor current setpoint. During normal operation the P-channel power MOSFET is turned on when the clock leading edge sets the SR latch through the S input. The P-channel MOSFET is turned off through the SR latch R input when the differential voltage from \( V_{IN} \) to SENSE is greater than the peak inductor current setpoint and the current comparator, ICMP, trips high.

Power CAP and \( V_{IN} \) Undervoltage Lockout (UVLO)

Power for the P-channel MOSFET gate driver is derived from the CAP pin. The CAP pin is regulated to 8V below \( V_{IN} \) in order to provide efficient P-channel operation. The power for the \( V_{CAP} \) supply comes from an internal LDO, which regulates the \( V_{IN}-\text{CAP} \) differential voltage. A minimum capacitance of 0.1\( \mu \)F (low ESR ceramic) is required between \( V_{IN} \) and CAP to assure stability.

For \( V_{IN} \leq 8\text{V} \), the LDO will be in dropout and the CAP voltage will be at ground, i.e., the \( V_{IN}-\text{CAP} \) differential voltage will equal \( V_{IN} \). If \( V_{IN}-\text{CAP} \) is less than 3.25V (typical), the LTC3863 enters a UVLO state where the GATE is prevented from switching and most internal circuitry is shut down. In order to exit UVLO, the \( V_{IN}-\text{CAP} \) voltage would have to exceed 3.5V (typical).

Shutdown and Soft-Start

When the RUN pin is below 0.7V, the controller and most internal circuits are disabled. In this micropower shutdown state, the LTC3863 draws only 7\( \mu \)A. Releasing the RUN pin allows a small internal pull-up current to pull the RUN pin above 1.26V and enable the controller. The RUN pin can be pulled up to an external supply of up to 60V or it can be driven directly by logic levels.
OPERATION

The start-up of the output voltage \( V_{OUT} \) is controlled by
the voltage on the SS pin. When the voltage on the SS
pin is less than the 0.8V internal reference, the \( V_{FB} \) pin is
regulated to the voltage on the SS pin. This allows the SS
pin to be used to program a soft-start by connecting an
external capacitor from the SS pin to signal ground. An
internal 10µA pull-up current charges this capacitor, creat-
ing a voltage ramp on the SS pin. As the SS voltage rises
from 0V to 0.8V, the output voltage \( V_{OUT} \) rises smoothly
from zero to its final value.

Alternatively, the SS pin can be used to cause the start-up of
\( V_{OUT} \) to track that of another supply. Typically, this requires
connecting the SS pin to an external resistor divider from
the other supply to ground (see Applications Information).
Under shutdown or UVLO, the SS pin is pulled to ground
and prevented from ramping up.

If the slew rate of the SS pin is greater than 1.2V/ms, the
output will track an internal soft-start ramp instead of the
SS pin. The internal soft-start will guarantee a smooth
start-up of the output under all conditions, including in the
case of a short-circuit recovery where the output voltage
will recover from near ground.

Light Load Current Operation (Burst Mode Operation
or Pulse-Skipping Mode)

The LTC3863 can be enabled to enter high efficiency Burst
Mode operation or pulse-skipping mode at light loads. To
select pulse-skipping operation, tie the PLLIN/MODE pin
to signal ground. To select Burst Mode operation, float
the PLLIN/MODE pin.

In Burst Mode operation, if the \( V_{FB} \) is higher than the refer-
ence voltage, the error amplifier will decrease the voltage
on the ITH pin. When the ITH voltage drops below 0.425V,
the internal sleep signal goes high, enabling sleep mode.
The ITH pin is then disconnected from the output of the
error amplifier and held at 0.55V.

In sleep mode, much of the internal circuitry is turned
off, reducing the quiescent current to 70µA while the
load current is supplied by the output capacitor. As the
output voltage and hence the feedback voltage decreases,
the error amplifier’s output will rise. When the output
voltage drops enough, the ITH pin is reconnected to the
output of the error amplifier, the sleep signal goes low,
and the controller resumes normal operation by turning
on the external P-channel MOSFET on the next cycle of
the internal oscillator. In Burst Mode operation, the peak
inductor current has to reach at least 25% of current limit
for the current comparator, ICMP, to trip and turn the
P-channel MOSFET back off, even though the ITH voltage
may indicate a lower current setpoint value.

When the PLLIN/MODE pin is connected for pulse-skipping
mode, the LTC3863 will skip pulses during light loads. In
this mode, ICMP may remain tripped for several cycles and
force the external MOSFET to stay off, thereby skipping
pulses. This mode offers the benefits of smaller output
ripple, lower audible noise, and reduced RF interference,
at the expense of lower efficiency when compared to Burst
Mode operation.

Frequency Selection and Clock Synchronization

The switching frequency of the LTC3863 can be selected
using the FREQ pin. If the PLLIN/MODE pin is not being
driven by an external clock source, the FREQ pin can be
tied to signal ground, floated, or programmed through an
external resistor. Tying FREQ pin to signal ground selects
350kHz, while floating selects 535kHz. Placing a resistor
between FREQ pin and signal ground allows the frequency
to be programmed between 50kHz and 850kHz.

The phase-locked loop (PLL) on the LTC3863 will syn-
chronize the internal oscillator to an external clock source
when connected to the PLLIN/MODE pin. The PLL forces
the turn-on edge of the external P-channel MOSFET to be
aligned with the rising edge of the synchronizing signal.
OPERATION

The oscillator’s default frequency is based on the operating frequency set by the FREQ pin. If the oscillator’s default frequency is near the external clock frequency, only slight adjustments are needed for the PLL to synchronize the external P-channel MOSFET’s turn-on edge to the rising edge of the external clock. This allows the PLL to lock rapidly without deviating far from the desired frequency.

The PLL is guaranteed from 75kHz to 750kHz. The clock input levels should be greater than 2V for HI and less than 0.5V for LO.

Fault Protection

When the $V_{FB}$ voltage is above $+10\%$ of the regulated voltage of 0.8V, this is considered as an overvoltage condition and the external P-MOSFET is immediately turned off and prevented from ever turning on until $V_{FB}$ returns below $+7.5\%$.

In the event of an output short circuit or overcurrent condition that causes the output voltage to drop significantly while in current limit, the LTC3863 operating frequency will fold back. Anytime the output feedback $V_{FB}$ voltage is less than 50% of the 0.8V internal reference (i.e., 0.4V), frequency foldback is active. The frequency will continue to drop as $V_{FB}$ drops until reaching a minimum foldback frequency of about 18% of the setpoint frequency. Frequency foldback is designed, in combination with peak current limit, to limit current in start-up and short-circuit conditions. Setting the foldback frequency as a percentage of operating frequency assures that start-up characteristics scale appropriately with operating frequency.
The LTC3863 is a nonsynchronous inverting, current mode, constant frequency PWM controller. It drives an external P-channel power MOSFET which connects to a Schottky power diode acting as the commutating catch diode. The input range extends from 3.5V to 60V. The output range has no theoretical minimum or maximum, but the duty factor and external components practically limit the output to one-tenth and ten times the input voltage. Higher output ratios can be obtained with transformers and more efficient external components.

The LTC3863 offers a highly efficient Burst Mode operation with 70µA quiescent current, which delivers outstanding efficiency in light load operation. The LTC3863 is a low pin count, robust and easy-to-use inverting power supply solution in applications which require high efficiency and operate with widely varying input and output voltages.

The typical application on the front page is a basic LTC3863 application circuit. The LTC3863 can sense the inductor current through a high side series sense resistor, RSENSE, placed between VIN and the source of the external P-channel MOSFET. Once the required output voltage and operating frequency have been determined, external component selection is driven by load requirements, and begins with the selection of inductor and RSENSE. Next, the power MOSFET and catch diode are selected. Finally, input and output capacitors are selected.

Output Voltage Programming

The output voltage is programmed by connecting a feedback resistor divider from the output to the VFB pin as shown in Figure 1. The output voltage in steady-state operation is set by the feedback resistors according to the equation:

\[ V_{OUT} = -0.8V \cdot \frac{R_{FB1}}{R_{FB2}} \]

Great care should be taken to route the VFB and VFBN lines away from noise sources, such as the inductor or SW node or the GATE signal that drives the external P-channel MOSFET.

The integrator capacitor, CFB2, should be sized to ensure the negative sense amplifier gain rolls off and limits high frequency gain peaking in the DC/DC control loop. The integrator capacitor pole can be safely set to be two times the switching frequency without affecting the DC/DC phase margin according to the following equation. It is highly recommended that CFB2 be used in most applications.

\[ C_{FB2} = \frac{1}{2 \cdot \pi \cdot 2 \cdot R_{FB2} \cdot FREQ_{SW}} \]

The feedback resistor RFB2 placed from the VFBN pin to the VFB pin is driven from VFB by an internal amplifier with limited VFB output current capability. For Operation at VIN down to 3.5V, it is recommended to limit the VFB output current to 100µA, and RFB2 should be no smaller than 8K. For VIN always greater than 6V, it is recommended to limit the current to 250µA, and RFB2 should be no smaller than 3.2K. For minimum VIN between 3.5V and 6V, add 75µA for each volt VIN-min is above 3.5V to the maximum current until reaching a maximum of 250µA at 6VIN, and minimum RFB2 would be 0.8V/lo-max.
Switching Frequency and Clock Synchronization

The choice of operating frequency is a trade-off between efficiency and component size. Lowering the operating frequency improves efficiency by reducing MOSFET switching losses but requires larger inductance and/or capacitance to maintain low output ripple voltage. Conversely, raising the operating frequency degrades efficiency but reduces component size.

The LTC3863 can free-run at a user programmed switching frequency, or it can synchronize with an external clock to run at the clock frequency. When the LTC3863 is synchronized, the GATE pin will synchronize in phase with the rising edge of the applied clock in order to turn the external P-channel MOSFET on. The switching frequency of the LTC3863 is programmed with the FREQ pin, and the external clock is applied at the PLLIN/MODE pin. Table 1 highlights the different states in which the FREQ pin can be used in conjunction with the PLLIN/MODE pin.

<table>
<thead>
<tr>
<th>FREQ PIN</th>
<th>PLLIN/MODE PIN</th>
<th>FREQUENCY</th>
</tr>
</thead>
<tbody>
<tr>
<td>OV</td>
<td>DC Voltage</td>
<td>350kHz</td>
</tr>
<tr>
<td>Floating</td>
<td>DC Voltage</td>
<td>535kHz</td>
</tr>
<tr>
<td>Resistor to GND</td>
<td>DC Voltage</td>
<td>50kHz to 850kHz</td>
</tr>
<tr>
<td>Either of the Above</td>
<td>External Clock</td>
<td>Phase Locked to External Clock</td>
</tr>
</tbody>
</table>

The free-running switching frequency can be programmed from 50kHz to 850kHz by connecting a resistor from FREQ pin to signal ground. The resulting switching frequency as a function of resistance on the FREQ pin is shown in Figure 2.

Set the free-running frequency to the desired synchronization frequency using the FREQ pin so that the internal oscillator is prebiased approximately to the synchronization frequency. While it is not required that the free-running frequency be near the external clock frequency, doing so will minimize synchronization time.

Inductor Selection

Operating frequency, inductor selection, capacitor selection and efficiency are interrelated. Higher operating frequencies allow the use of smaller inductors, smaller capacitors, but result in lower efficiency because of higher MOSFET gate charge and transition losses. In addition to this basic trade-off, the selection of inductor value is also influenced by other factors.

Small inductor values result in large inductor ripple currents, large output voltage ripples and low efficiency due to higher core and conduction loss. Large inductor ripple currents result in high inductor peak currents, which require physically large inductors with large magnetic cross sections and higher saturation current ratings.

The value of the inductor can also impact the stability of the feedback loop. In continuous mode, the buck-boost converter transfer function has a right-half plane zero at a frequency that is inversely proportional to the value of the inductor. As a result, large inductor values can move this zero to a frequency that is low enough to degrade the phase margin of the feedback loop. Large inductor values also tend to degrade stability due to low noise margin caused from low ripple current. Additionally, large value inductors can lead to slow transient response due to slow inductor current ramping time.
APPLICATIONS INFORMATION

For an inverting buck-boost converter operating in continuous conduction mode (CCM), given the desired input, output voltages and switching frequency, the peak-to-peak inductor ripple current is determined by the inductor value:

\[ \Delta I_L(CCM) = \frac{V_{IN} \cdot D}{L \cdot f} = \frac{V_{IN} \cdot (|V_{OUT}| + V_D)}{L \cdot f \cdot (V_{IN} + |V_{OUT}| + V_D)} \]

where \( V_D \) is the diode forward conduction voltage. In cases where \( V_{OUT} \gg V_D \), \( V_D \) can be ignored. \( D \) is the duty factor and is given as:

\[ D = \frac{|V_{OUT}| + V_D}{V_{IN} + |V_{OUT}| + V_D} \quad (0 < D < 1) \]

The duty factor increases with increasing \( V_{OUT} \) and decreasing \( V_{IN} \). For a given \( V_{OUT} \), the maximum duty factor occurs at minimum \( V_{IN} \).

A typical starting point for selecting an inductor is to choose the inductance such that the maximum peak-to-peak inductor ripple current, \( \Delta I_L(MAX) \), is set to 40% ~ 50% of the inductor average current, \( I_L(AVG) \), at maximum load current. Since \( \Delta I_L(MAX) \) occurs at maximum \( V_{IN} \) in continuous mode, the inductance is calculated at maximum \( V_{IN} \):

\[ L = \frac{V_{IN(MAX)}^2 \cdot (|V_{OUT}| + V_D)}{0.4 \cdot I_{OUT(MAX)} \cdot f \cdot (V_{IN(MAX)} + |V_{OUT}| + V_D)^2} \]

The inductance can be further adjusted to achieve specific design optimization of efficiency, output ripple, component size and loop response.

Once the inductance value has been determined, the type of inductor must be selected. Core loss is independent of core size for a given inductor value, but it is very dependent on the inductance selected. As inductance increases, core losses decrease. Unfortunately, increased inductance requires more turns of wire and therefore, copper losses will increase.

High efficiency converters generally cannot tolerate the core loss of low cost powdered iron cores, forcing the use of more expensive ferrite materials. Ferrite designs have very low core loss and are preferred at high switching frequencies, so design goals can concentrate on copper loss and preventing saturation. Ferrite core material saturates hard, which means that inductance collapses abruptly when the peak design current is exceeded. This will result in an abrupt increase in inductor ripple current and output voltage ripple. Do not allow the core to saturate!

A variety of inductors are available from manufacturers such as Sumida, Panasonic, Coiltronics, Coilcraft, Toko, Vishay, Pulse and Würth.

Current Sensing and Current Limit Programming

The LTC3863 senses the inductor current through a current sense resistor, \( R_{SENSE} \), placed across the \( V_{IN} \) and SENSE pins. The voltage across the resistor, \( V_{SENSE} \), is proportional to inductor current and in normal operation is compared to the peak inductor current setpoint. An inductor current limit condition is detected when \( V_{SENSE} \) exceeds 95mV. When the current limit threshold is exceeded, the P-channel MOSFET is immediately turned off by pulling the GATE voltage to \( V_{IN} \) regardless of the controller input.

The peak inductor current limit is equal to:

\[ I_{L(PEAK)} = \frac{95 \text{mV}}{R_{SENSE}} \]

This inductor current limit would translate to an output current limit based on the inductor ripple and duty factor:

\[ I_{OUT(LIMIT)} = \left( \frac{95 \text{mV}}{R_{SENSE}} - \frac{\Delta I_L}{2} \right) \cdot (1 - D) \]
APPLICATIONS INFORMATION

The SENSE pin is a high impedance input with a maximum leakage of ±2µA. Since the LTC3863 is a peak current mode controller, noise on the SENSE pin can create pulse width jitter. Careful attention must be paid to the layout of RSENSE. To ensure the integrity of the current sense signal, VSENSE, the traces from VIN and SENSE pins should be short and run together as a differential pair and Kelvin (4-wire) connected across RSENSE (Figure 3).

The LTC3863 has internal filtering of the current sense voltage which should be adequate in most applications. However, adding a provision for an external filter offers added flexibility and noise immunity, should it be necessary. The filter can be created by placing a resistor from the RSENSE resistor to the SENSE pin and a capacitor across the VIN and SENSE pins.

The drain-to-source breakdown voltage must meet the following condition:

\[ BVDSS > V_{IN(\text{MAX})} + |V_{OUT}| + V_D \]

The gate driver bias voltage \( V_{IN-V_{CAP}} \) is set by an internal LDO regulator. In normal operation, the CAP pin will be regulated to 8V below VIN. A minimum 0.1µF capacitor is required across the VIN and CAP pins to ensure LDO stability. If required, additional capacitance can be added to accommodate higher gate currents without voltage droop. In shutdown and Burst Mode operation, the CAP LDO is turned off. In the event of CAP leakage to ground, the CAP voltage is limited to 9V by a weak internal clamp from VIN to CAP. As a result, a minimum 10V \( V_{GS} \) rated MOSFET is required.

The power dissipated by the P-channel MOSFET when the LTC3863 is in continuous conduction mode is given by:

\[
P_{PMOS} \approx D \cdot \left( \frac{I_{OUT}}{1-D} \right)^2 \cdot \rho_T \cdot R_{DS(ON)} \\
+ f \cdot C_{\text{MILLER}} \cdot \frac{(V_{IN} + |V_{OUT}| + V_D)^2}{2} \cdot I_{OUT} \\
\cdot \left[ \frac{R_{DN}}{(V_{IN} - V_{CAP} - V_{MILLER})} + \frac{R_{UP}}{V_{MILLER}} \right]
\]

where D is duty factor, \( R_{DS(ON)} \) is on-resistance of P-channel MOSFET, \( \rho_T \) is temperature coefficient of on-resistance, \( R_{DN} \) is the pull-down driver resistance specified at 0.9Ω typical and \( R_{UP} \) is the pull-up driver resistance specified at 2Ω typical. \( V_{MILLER} \) is the Miller effective \( V_{GS} \) voltage and is taken graphically from the power MOSFET data sheet.

Power MOSFET Selection

The LTC3863 drives a P-channel power MOSFET that serves as the main switch for the nonsynchronous inverting converter. Important P-channel power MOSFET parameters include drain-to-source breakdown voltage \( V_{DSS} \), threshold voltage \( V_{GS(TH)} \), on-resistance \( R_{DS(ON)} \), gate-to-drain reverse transfer capacitance \( C_{RSS} \), maximum drain current \( I_{D(MAX)} \), and the MOSFET’s thermal resistance \( \theta_{JC(MOSFET)} \) and \( \theta_{JA(MOSFET)} \).
APPLICATIONS INFORMATION

The power MOSFET input capacitance, \( C_{MILLER} \), is the most important selection criteria for determining the transition loss term in the P-channel MOSFET but is not directly specified on MOSFET data sheets. \( C_{MILLER} \) is a combination of several components, but it can be derived from the typical gate charge curve included on most data sheets (Figure 4).

The curve is generated by forcing a constant current out of the gate of a common-source connected P-channel MOSFET that is loaded with a resistor, and then plotting the gate voltage versus time. The initial slope is the effect of the gate-to-source and gate-to-drain capacitances. The flat portion of the curve is the result of the Miller multiplication effect of the drain-to-gate capacitance as the drain voltage rises across the resistor load. The Miller charge (the increase in coulombs on the horizontal axis from a to b while the curve is flat) is specified for a given \( V_{SD} \) test voltage, but can be adjusted for different \( V_{SD} \) voltages by multiplying by the ratio of the adjusted \( V_{SD} \) to the curve specified \( V_{SD} \) value. A way to estimate the \( C_{MILLER} \) term is to take the change in gate charge from points a and b (or the parameter \( Q_{GD} \) on a manufacturer’s data sheet) and dividing it by the specified \( V_{SD} \) test voltage, \( V_{SD(\text{TEST})} \):

\[
C_{MILLER} = \frac{Q_{GD}}{V_{SD(\text{TEST})}}
\]

The term with \( C_{MILLER} \) accounts for transition loss, which is highest at high input voltages. For \( V_{IN} < 20V \), the high current efficiency generally improves with larger MOSFETs, while for \( V_{IN} > 20V \), the transition losses rapidly increase to the point that the use of a higher \( R_{DS(ON)} \) device with lower \( C_{MILLER} \) actually provides higher efficiency.

Schottky Diode Selection

When the P-channel MOSFET is turned off, a power Schottky diode is required to function as a commutating diode to carry the inductor current. The average forward diode current is independent of duty factor and is described as:

\[
I_{F(AVG)} = I_{OUT}
\]

The worst-case condition for diode conduction is a short-circuit condition where the Schottky must handle the maximum current as its duty factor approaches 100% (and the P-channel MOSFET’s duty factor approaches 0%). The diode therefore must be chosen carefully to meet worst-case voltage and current requirements. A good practice is to choose a diode that has a forward current rating two times higher than \( I_{OUT(\text{MAX})} \).

Once the average forward diode current is calculated, the power dissipation can be determined. Refer to the Schottky diode data sheet for the power dissipation, \( P_{DIODE} \), as a function of average forward current, \( I_{F(AVG)} \). \( P_{DIODE} \) can

![Figure 4. (4a) Typical P-Channel MOSFET Gate Charge Characteristics and (4b) Test Set-Up to Generate Gate Charge Curve](image-url)
also be iteratively determined by the two equations below, where $V_F(I_{OUT,TJ})$ is a function of both $I_F(AVG)$ and junction temperature $T_J$. Note that the thermal resistance, $\theta_{JA(DIODE)}$, given in the data sheet is typical and can be highly layout dependent. It is therefore important to make sure that the Schottky diode has adequate heat sinking.

$$T_J = P_{DIODE} \cdot \theta_{JA(DIODE)}$$

$$P_{DIODE} = I_F(AVG) \cdot V_D(I_{OUT,TJ})$$

The Schottky diode forward voltage is a function of both $I_F(AVG)$ and $T_J$, so several iterations may be required to satisfy both equations. The Schottky forward voltage, $V_D$, should be taken from the Schottky diode data sheet curve showing instantaneous forward voltage. The forward voltage will change as a function of both $T_J$ and $I_F(AVG)$. The nominal forward voltage will also tend to increase as the reverse breakdown voltage increases. It is therefore advantageous to select a Schottky diode appropriate to the input voltage requirements. The diode reverse breakdown voltage must meet the following condition:

$$V_R > V_{IN(MAX)} + |V_{OUT}|$$

C_IN and C_OUT Selection

The input and output capacitance, $C_{IN}/C_{OUT}$, are required to filter the square wave current through the P-channel MOSFET and diode respectively. Use a low ESR capacitor sized to handle the maximum RMS current:

$$I_{CIN(RMS)} = I_{COUT(RMS)} = I_{OUT} \cdot \sqrt{\frac{|V_{OUT}| + V_D}{V_{IN}}}$$

The formula shows that the RMS current is greater than the maximum $I_{OUT}$ when $V_{OUT}$ is greater than $V_{IN}$. Choose capacitors with higher RMS rating with sufficient margin. Note that ripple current ratings from capacitor manufacturers are often based on only 2000 hours of life, which makes it advisable to derate the capacitor.

The selection of $C_{OUT}$ is primarily determined by the ESR required to minimize voltage ripple and load step transients. The $\Delta V_{OUT}$ is approximately bounded by:

$$\Delta V_{OUT} \leq I_{L(PEAK)} \cdot ESR + \frac{I_{OUT} \cdot D}{f \cdot C_{OUT}}$$

where $I_{L(PEAK)}$ is the peak inductor current and it’s given as:

$$I_{L(PEAK)} = \frac{I_{OUT} \cdot (V_{IN} + |V_{OUT}| + V_D)}{V_{IN}} + \frac{V_{IN} \cdot (|V_{OUT}| + V_D)}{2 \cdot L \cdot f \cdot (V_{IN} + |V_{OUT}| + V_D)}$$

Since $I_{L(PEAK)}$ and $D$ reach their maximum values at minimum $V_{IN}$, the output voltage ripple is highest at minimum $V_{IN}$ and maximum $I_{OUT}$. Typically, once the ESR requirement is satisfied, the capacitance is adequate for filtering and has the necessary RMS current rating.

Multiple capacitors placed in parallel may be needed to meet the ESR and RMS current handling requirements. Dry tantalum, specialty polymer, aluminum electrolytic and ceramic capacitors are all available in surface mount packages. Specialty polymer capacitors offer very low ESR but have lower specific capacitance than other types. Tantalum capacitors have the highest specific capacitance, but it is important to only use types that have been surge tested for use in switching power supplies. Aluminum electrolytic capacitors have significantly higher ESR, but can be used in cost-sensitive applications provided that consideration is given to ripple current ratings and long-term reliability. Ceramic capacitors have excellent low ESR characteristics but can have a high voltage coefficient and audible piezoelectric effects.

The high Q of ceramic capacitors with trace inductance can also lead to significant ringing. When used as input capacitors, care must be taken to ensure that ringing from inrush currents and switching does not pose an overvoltage hazard to the power switch and controller. To dampen input voltage transients, add a small 5μF to 40μF aluminum electrolytic capacitor with an ESR in the range of 0.5Ω to 2Ω. High performance through-hole capacitors may also be used, but an additional ceramic capacitor in parallel is recommended to reduce the effect of lead inductance.
**APPLICATIONS INFORMATION**

**Discontinuous and Continuous Operation**

The LTC3863 operates in discontinuous conduction (DCM) until the load current is high enough for the inductor current to be positive at the end of the switching cycle. The output load current at the continuous/discontinuous boundary, $I_{OUT(CDB)}$, is given by the following equation:

$$I_{OUT(CDB)} = \frac{V_{IN(MAX)}^2 \cdot (|V_{OUT}| + V_D)}{2 \cdot L \cdot f \cdot (V_{IN(MAX)} + |V_{OUT}| + V_D)^2}$$

The continuous/discontinuous boundary is inversely proportional to the inductor value. Therefore, if required, $I_{OUT(CDB)}$ can be reduced by increasing the inductor value.

**External Soft-Start and Output Tracking**

Start-up characteristics are controlled by the voltage on the SS pin. When the voltage on the SS pin is less than the internal 0.8V reference, the LTC3863 regulates the $V_{FB}$ pin voltage to the voltage on the SS pin. When the SS pin is greater than the internal 0.8V reference, the $V_{FB}$ pin voltage regulates to the 0.8V internal reference. The SS pin can be used to program an external soft-start function or to allow $V_{OUT}$ to track another supply during start-up.

Soft-start is enabled by connecting a capacitor from the SS pin to ground. An internal 10µA current source charges the capacitor, providing a linear ramping voltage at the SS pin that causes $V_{OUT}$ to rise smoothly from 0V to its final regulated value. The total soft-start time will be approximately:

$$t_{SS} = C_{SS} \cdot \frac{0.8V}{10\mu A}$$

When the LTC3863 is configured to track another supply, a voltage divider can be used from the tracking supply to the SS pin to scale the ramp rate appropriately. Two common implementations of tracking as shown in Figure 5a are coincident and ratiometric. For coincident tracking,
choose the divider ratio for the external supply as shown in Figure 5b. Ratiometric tracking could be achieved by using a different ratio than the feedback (Figure 5b).

Note that the soft-start capacitor charging current is always flowing, producing a small offset error. To minimize this error, select the tracking resistive divider values to be small enough to make this offset error negligible.

**Short-Circuit Faults: Current Limit and Foldback**

The inductor current limit is inherently set in a current mode controller by the maximum sense voltage and $R_{\text{SENSE}}$. In the LTC3863, the maximum sense voltage is 95mV, measured across the inductor sense resistor, $R_{\text{SENSE}}$, placed across the $V_{\text{IN}}$ and $\text{SENSE}$ pins. The output current limit is approximately:

$$I_{\text{LIMIT(MIN)}} = \frac{95 \text{mV}}{R_{\text{SENSE}}} - \frac{\Delta I_L}{2} \cdot \frac{V_{\text{IN(MIN)}}}{(V_{\text{IN(MIN)}} + |V_{\text{OUT}}| + V_D)}$$

The current limit must be chosen to ensure that $I_{\text{LIMIT(MIN)}} > I_{\text{OUT(MAX)}}$ under all operating conditions. The inductor current limit should be greater than the inductor current required to produce maximum output power at worst-case efficiency. For the LTC3863, both minimum and maximum $V_{\text{IN}}$ cases should be checked to determine the worst-case efficiency.

Short-circuit fault protection is assured by the combination of current limit and frequency foldback. When the output feedback voltage, $V_{FB}$, drops below 0.4V, the operating frequency, $f$, will fold back to a minimum value of $0.18 \cdot f$ when $V_{FB}$ reaches 0V. Both current limit and frequency foldback are active in all modes of operation. In a short-circuit fault condition, the output current is first limited by current limit and then further reduced by folding back the operating frequency as the short becomes more severe. The worst-case fault condition occurs when $V_{\text{OUT}}$ is shorted to ground.

**Short-Circuit Recovery and Internal Soft-Start**

An internal soft-start feature guarantees a maximum positive output voltage slew rate in all operational cases. In a short-circuit recovery condition for example, the output recovery rate is limited by the internal soft-start so that output voltage overshoot and excessive inductor current buildup is prevented.

The internal soft-start voltage and the external SS pin operate independently. The output will track the lower of the two voltages. The slew rate of the internal soft-start voltage is roughly 1.2V/ms, which translates to a total soft-start time of 650µs. If the slew rate of the SS pin is greater than 1.2V/ms the output will track the internal soft-start ramp. To assure robust fault recovery, the internal soft-start feature is active in all operational cases. If a short-circuit condition occurs which causes the output to drop significantly, the internal soft-start will assure a soft recovery when the fault condition is removed.

The internal soft-start assures a clean soft ramp-up from any fault condition that causes the output to droop, guaranteeing a maximum ramp rate in soft-start, short-circuit fault release. Figure 6 illustrates how internal soft-start controls the output ramp-up rate under varying scenarios.
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**VIN Undervoltage Lockout (UVLO)**

The LTC3863 is designed to accommodate applications requiring widely varying power input voltages from 3.5V to 60V. To accommodate the cases where $V_{IN}$ drops significantly once in regulation, the LTC3863 is guaranteed to operate down to a $V_{IN}$ of 3.5V over the full temperature range.

The implications of both the UVLO rising and UVLO falling specifications must be carefully considered for low $V_{IN}$ operation. The UVLO threshold with $V_{IN}$ rising is typically 3.5V (with a maximum of 3.8V) and UVLO falling is typically 3.25V (with a maximum of 3.5V). The operating input voltage range of the LTC3863 is guaranteed to be 3.5V to 60V over temperature, but the initial $V_{IN}$ ramp must exceed 3.8V to guarantee start-up.

**Minimum On-Time Considerations**

The minimum on-time, $t_{ON\text{(MIN)}}$, is the smallest time duration that the LTC3863 is capable of turning on the power MOSFET, and is typically 220ns. It is determined by internal timing delays and the gate charge required to turn on the MOSFET. Low duty cycle applications may approach this minimum on-time limit, so care should be taken to ensure that:

$$t_{ON\text{(MIN)}} < \frac{(|V_{OUT}| + V_D)}{f \cdot (V_{IN\text{(MAX)}} + |V_{OUT}| + V_D)}$$

If the duty cycle falls below what can be accommodated by the minimum on-time, the controller will skip cycles. However, the output voltage will continue to regulate.

**Efficiency Considerations**

The percent efficiency of a switching regulator is equal to the output power divided by the input power times 100%. It is often useful to analyze individual losses to determine the dominant contributors and therefore where efficiency improvements can be made. Percent efficiency can be expressed as:

$$\% \text{ Efficiency} = 100\% - (L_1 + L_2 + L_3 + \ldots)$$

where $L_1$, $L_2$, $L_3$, etc., are the individual losses as a percentage of input power.

Although all dissipative elements in the circuit produce losses, four main sources account for most of the losses in LTC3863 application circuits.

1. **Conduction Loss**: Conduction losses result from the P-channel MOSFET $R_{DS\text{(ON)}}$, inductor resistance $DCR$, the current sense resistor $R_{SENSE}$, and input and output capacitor $ESR$. The current through $DCR$ is continuous. The currents through both the P-channel MOSFET and Schottky diode are discontinuous. The following equation may be used to determine the total conduction loss ($P_{COND}$) in continuous conduction mode:

$$P_{COND} = \frac{I_{OUT}^2}{(1-D)^2} + \frac{\Delta I_{L}^2}{12} \left[ R_{DCR} + D \cdot (R_{DS\text{(ON)}} + R_{SENSE} + R_{ESR\text{(CIN)}}) \right] + \left(1-D\right) \cdot R_{ESR\text{(COUT)}}$$

2. **Transition Loss**: Transition loss of the P-channel MOSFET becomes significant only when operating at high input voltages (typically 20V or greater.) The P-channel transition losses ($P_{PMOSTRL}$) can be determined from the following equation:

$$P_{PMOSTRL} = \frac{f \cdot C_{MILLER} \cdot (V_{IN} + |V_{OUT}| + V_D)^2}{2} \left[ \frac{R_{DN}}{1-D} \left(\frac{R_{UP}}{V_{C_\text{IN}} - V_{MILLER}} - \frac{R_{MILLER}}{V_{MILLER}} \right) \right]$$
3. Gate Charging Loss: Charging and discharging the gate of the MOSFET will result in an effective gate charging current. Each time the P-channel MOSFET gate is switched from low to high and low again, a packet of charge, \( dQ \), moves from the capacitor across \( V_{IN} - V_{CAP} \) and is then replenished from ground by the internal \( V_{CAP} \) regulator. The resulting \( dQ/dt \) current is a current out of \( V_{IN} \) flowing to ground. The total power loss in the controller including gate charging loss is determined by the following equation:

\[
P_{CNTRL} = V_{IN} \times (I_Q + f \times Q_{G(PMOSFET)})
\]

4. Schottky Loss: The Schottky loss is independent of duty factors. The critical component is the Schottky forward voltage as a function of junction temperature and current. The Schottky power loss is given by the equation:

\[
P_{DIODE} = I_{OUT} \times V_{D(IOUT,TJ)}
\]

When making adjustments to improve efficiency, the input current is the best indicator of changes in efficiency. If changes cause the input current to decrease, then the efficiency has increased. If there is no change in input current, there is no change in efficiency.

OPTI-LOOP® Compensation

OPTI-LOOP compensation, through the availability of the ITH pin, allows the transient response to be optimized for a wide range of loads and output capacitors. The ITH pin not only allows optimization of the control loop behavior but also provides a test point for the regulator’s DC-coupled and AC-filtered closed-loop response. The DC step, rise time and settling at this test point truly reflects the closed-loop response. Assuming a predominantly second order system, phase margin and/or damping factor can be estimated using the percentage of overshoot seen at this pin. The bandwidth can also be estimated by examining the rise time at this pin.

The ITH series \( R_{ITH} \cdot C_{ITH1} \) filter sets the dominant pole-zero loop compensation. Additionally, a small capacitor placed from the ITH pin to signal ground, \( C_{ITH2} \), may be required to attenuate high frequency noise. The values can be modified to optimize transient response once the final PCB layout is done and the particular output capacitor type and value have been determined. The output capacitors need to be selected because their various types and values determine the loop feedback factor gain and phase. An output current pulse of 20% to 100% of full load current having a rise time of 1μs to 10μs will produce output voltage and ITH pin waveforms that will give a sense of the overall loop stability without breaking the feedback loop. The general goal of OPTI-LOOP compensation is to realize a fast but stable ITH response with minimal output droop due to the load step. For a detailed explanation of OPTI-LOOP compensation, refer to Application Note 76.

Switching regulators take several cycles to respond to a step in load current. When a load step occurs, \( V_{OUT} \) immediately shifts by an amount equal to \( \Delta I_{LOAD} \times ESR \), where ESR is the effective series resistance of \( C_{OUT} \). \( \Delta I_{LOAD} \) also begins to charge or discharge \( C_{OUT} \), generating a feedback error signal used by the regulator to return \( V_{OUT} \) to its steady-state value. During this recovery time, \( V_{OUT} \) can be monitored for overshoot or ringing that would indicate a stability problem.

Connecting a resistive load in series with a power MOSFET, then placing the two directly across the output capacitor and driving the gate with an appropriate signal generator is a practical way to produce a realistic load-step condition. The initial output voltage step resulting from the step change in output current may not be within the bandwidth of the feedback loop, so this signal cannot be used to determine phase margin. This is why it is better to look at the ITH pin signal which is in the feedback loop and is the filtered and compensated feedback loop response.

The gain of the loop increases with \( R_{ITH} \) and the bandwidth of the loop increases with decreasing \( C_{ITH1} \). If \( R_{ITH} \) is increased by the same factor that \( C_{ITH1} \) is decreased, the zero frequency will be kept the same, thereby keeping the phase the same in the most critical frequency range of
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the feedback loop. The output voltage settling behavior is related to the stability of the closed-loop system and will demonstrate overall performance of the regulator.

In some applications, a more severe transient can be caused by switching in loads with large (>10μF) input capacitors. If the switch connecting the load has low resistance and is driven quickly, then the discharged input capacitors are effectively put in parallel with C\textsubscript{OUT}, causing a rapid drop in V\textsubscript{OUT}. No regulator can deliver enough current to prevent this problem. The solution is to limit the turn-on speed of the load switch driver. A Hot Swap\textsuperscript{™} controller is designed specifically for this purpose and usually incorporates current limiting, short-circuit protection and soft-start.

Large-Signal Effects on ITH

Inverting controllers have a wide range of applications and operating conditions which affect compensation. Low switching frequencies and the inverting buck-boost right-half-plane zero can result in very low gain crossover frequency requirements. Low crossover frequencies often require a compensation R\textsubscript{ITH} and C\textsubscript{ITH} that are too small for the error amplifier output drive current on ITH of 100μA. The effect causes ITH to appear clamped in response to a transient load current step which causes excessive output droop.

An R\textsubscript{ITH} greater than 20k allows ITH to swing 1.5V with margin for temperature and part to part variation and should never have this issue. In applications with less severe transient load step requirements, R\textsubscript{ITH} can safely be set as low as 10k. We do not recommend less than 10k in any application. If R\textsubscript{ITH} is too small then either the operating frequency will need to be increased or the output capacitor increased to increase the R\textsubscript{ITH} required to stabilize the system. We strongly recommend that any system with an R\textsubscript{ITH} less than 20k be experimentally verified with worst-case load steps.

Design Example

Consider an inverting converter with the following specifications:

\[ V\textsubscript{IN} = 4.5V \text{ to } 55V, \quad V\textsubscript{OUT} = -5V, \quad I\textsubscript{OUT(MAX)} = 1.8A, \text{ and } f = 320kHz \]

Figure 7. Design Example (4.5V to 55V Input, –5V, 1.8A at 320kHz)
If \( RFB1 \) is chosen to be 187\( \Omega \), then \( RFB2 \) needs to be 30.1\( \Omega \). The FREQ pin is tied to signal ground in order to program the switching frequency to 350kHz. The on-time required to generate \(-5V\) output from \( 55V \) \( V_{IN} \) in continuous mode can be calculated as:

\[
t_{ON(CCM)} = \frac{5V + 0.5V}{320kHz \cdot (55V + 5V + 0.5V)} = 260ns
\]

This on-time, \( t_{ON} \), is larger than LTC3863’s minimum on-time with sufficient margin to prevent cycle skipping. Use a lower frequency if a larger on-time margin is needed to account for variations from minimum on-time and switching frequency. As load current decreases, the converter will eventually start cycle skipping.

Next, set the inductor value such that the inductor ripple current is 60\% of the average inductor current at maximum \( V_{IN} = 55V \) and full load = 1.8A:

\[
L = \frac{55V^2 \cdot (5V + 0.5V)}{0.6 \cdot 1.8A \cdot 320kHz \cdot (55V + 5V + 0.5V)^2} = 13.1\mu H
\]

Select a standard value of 12\( \mu H \).

The resulting ripple current at minimum \( V_{IN} \) of 4.5V is:

\[
\Delta I_L = \frac{4.5V \cdot (5V + 0.5V)}{12\mu H \cdot 320kHz \cdot (4.5V + 5V + 0.5V)} = 0.644A
\]

The boundary output current for continuous/discontinuous mode is calculated:

\[
I_{OUT(CDB)} = \frac{55V^2 \cdot (5V + 0.5V)}{2 \cdot 12\mu H \cdot 320kHz \cdot (55V + 5V + 0.5V)^2} = 0.59A
\]

The maximum inductor peak current occurs at minimum \( V_{IN} \) of 4.5V and full load of 1.8A where LTC3863 operates in continuous mode is:

\[
I_{L(Peak Max)} = \frac{1.8A \cdot (4.5V + 5V + 0.5V)}{4.5V} + \frac{\Delta I_L}{2} = 4A + \frac{0.644A}{2} = 4.32A
\]

Next, set the \( R_{SENSE} \) resistor value to ensure that the converter can deliver the maximum peak inductor current of 4.32A with sufficient margin to account for component variations and worst-case operating conditions. Using a 30\% margin factor:

\[
R_{SENSE} = \frac{95mV}{1.3 \cdot 4.32A} = 16.9m\Omega
\]

Use a more readily available 16m\( \Omega \) sense resistor. This results in peak inductor current limit:

\[
I_{L(Peak)} = \frac{95mV}{16m\Omega} = 5.94A
\]

Choose an inductor that has rated saturation current higher than 5.94A with sufficient margin.

The output current limit can be calculated from the peak inductor current limit and its minimum occurs at minimum \( V_{IN} \) of 5V:

\[
I_{LIMIT(MIN)} = \frac{95mV}{16m\Omega} - \frac{0.644A}{2} \cdot \frac{5V}{(4.5V + 5V + 0.5V)} = 2.8A
\]

In this example, 2.8A is the maximum output current the switching regulator can support at \( V_{IN} = 4.5V \). It is larger than the full load of 1.8A by a margin of 1A. If a larger margin is needed, use a smaller \( R_{SENSE} \).
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Next choose a P-channel MOSFET with the appropriate BV_{DSS} and I_D rating. The BV_{DSS} rating should be greater than (55V + 5V + V_D) with sufficient margin. In this example, a good choice is the Vishay Si7469DP (BV_{DSS} = 80V, I_D = 10A, R_{DS(on)} = 30mΩ, ρ_{100°C} = 1.8, V_{MILLER} = 3.2V, C_{MILLER} = 235pF, θ_{JA} = 24°C/W). The highest power dissipation and the resulting junction temperature for the P-channel MOSFET occurs at the minimum VIN of 5V and maximum output current of 1.8A. They can be calculated at T_A = 70°C as follows:

\[ D = \frac{5V + 0.5V}{4.5V + 5V + 0.5V} = 0.55 \]

\[ P_{PMOS} = 0.55 \cdot \left( \frac{1.8A}{1-0.55} \right)^2 \cdot 1.8 \cdot 30mΩ + \frac{320kHz \cdot 235pF \cdot (4.5V + | -5V | + 0.5V)^2}{2} \cdot 1.8A \cdot \left( \frac{0.9Ω}{4.5V - 3.2V} + \frac{2Ω}{3.2V} \right) \]

\[ \approx 0.475W + 0.020W = 0.495W \]

\[ T_J = 70°C + 0.495W \cdot 24°C/W = 82°C \]

The same calculations can be repeated for V_{IN(MAX)} = 55V:

\[ D = \frac{5V + 0.5V}{55V + 5V + 0.5V} = 0.091 \]

\[ P_{PMOS} = 0.091 \cdot \left( \frac{1.8A}{1-0.091} \right)^2 \cdot 1.8 \cdot 30mΩ + \frac{320kHz \cdot 235pF \cdot (55V + | -5V | + 0.5V)^2}{2} \cdot 1.8A \cdot \left( \frac{0.9Ω}{5V - 3.2V} + \frac{2Ω}{3.2V} \right) \]

\[ \approx 0.019W + 0.39W = 0.411W \]

\[ T_J = 70°C + 0.411W \cdot 24°C/W = 82°C \]

Next choose an appropriate Schottky diode that will handle the power requirements. The reverse voltage of the diode, V_R, should be greater than (55V + 5V). The Fairchild S38 Schottky diode is selected (V_F (3A, 125°C) = 0.45V, V_R = 80V, θ_{JA} = 55°C/W) for this application. The power dissipation and junction temperature at T_A = 70° and full load = 1.8A can be calculated as:

\[ P_{DIODE} = 1.8A \cdot 0.45V = 0.81W \]

\[ T_J = 70°C + 0.81W \cdot 55°C/W = 114°C \]

These power dissipation calculations show that careful attention to heat sinking will be necessary.

For the input bypass capacitors, choose low ESR ceramic capacitors that can handle the maximum RMS current at the minimum V_{IN} of 4.5V:

\[ I_{CIN(RMS)} = 1.8A \cdot \sqrt{\frac{| -5V |}{4.5V}} = 1.9A \]

C_{OUT} will be selected based on the ESR that is required to satisfy the output voltage ripple requirement. For this design, two 47μF ceramic capacitors are chosen to offer low ripple in both normal operation and in Burst Mode operation.

The selected C_{OUT} must support the maximum RMS operating current at a minimum V_{IN} of 4.5V:

\[ I_{CIN(RMS)} = 1.8A \cdot \sqrt{\frac{| -5V |}{4.5V}} = 1.9A \]

A soft-start time of 8ms can be programmed through a 0.1μF capacitor on the SS pin:

\[ C_{SS} = \frac{8ms \cdot 10μA}{0.8V} = 0.1μF \]

Loop compensation components on the ITH pin are chosen based on load step transient behavior (as described under OPTI-LOOP Compensation) and is optimized for stability. A pull-up resistor is used on the RUN pin for FMEA compliance (see Failure Modes and Effects Analysis).
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An application with complementary dual outputs of ±5V can be designed by using two LTC3863 parts with one configured into an inverting regulator and the other into a step-down buck regulator as shown in Figure 11. Refer to LTC3864 data sheet for the actual design of a buck output of 5V.

Gate Driver Component Placement, Layout and Routing

It is important to follow recommended power supply PC board layout practices such as placing external power elements to minimize loop area and inductance in switching paths. Be careful to pay particular attention to gate driver component placement, layout and routing.

The effective $C_{\text{CAP}}$ capacitance should be greater than 0.1μF minimum in all operating conditions. Operating voltage and temperature both decrease the rated capacitance to varying degrees depending on dielectric type. The LTC3863 is a PMOS controller with an internal gate driver and boot-strapped LDO that regulates the differential CAP voltage ($V_{\text{IN}} - V_{\text{CAP}}$) to 8V nominal. The $C_{\text{CAP}}$ capacitance needs to be large enough to assure stability and provide cycle-to-cycle current to the PMOS switch with minimum series inductance. We recommend a ceramic 0.47μF 16V capacitor with a high quality dielectric such as X5R or X7R. Some high current applications with large Qg PMOS switches may benefit from an even larger $C_{\text{CAP}}$ capacitance.

Figure 8 shows the LTC3863 Generic Application Schematic which includes an optional current sense filter and series gate resistor. Figure 9 illustrates the recommended gate driver component placement, layout and routing of the GATE, $V_{\text{IN}}$, SENSE and CAP pins and key gate driver components. It is recommended that the gate driver layout follow the example shown in Figure 9 to assure proper operation and long term reliability.

The LTC3863 gate driver should connect to the external power elements in the following manner. First route the $V_{\text{IN}}$ pin using a single low impedance isolated trace to the positive RSENSE resistor PAD without connection to the $V_{\text{IN}}$ plane. The reason for this precaution is that the $V_{\text{IN}}$ pin is internally Kelvin connected to the current sense comparator, internal $V_{\text{IN}}$ power and the PMOS gate driver. Connecting the $V_{\text{IN}}$ pin to the $V_{\text{IN}}$ power plane adds noise and can result in jitter or instability. Figure 9 shows a single $V_{\text{IN}}$ trace from the positive RSENSE pad connected to $C_{\text{SF}}$, $C_{\text{CAP}}$, $V_{\text{IN}}$ pad and $C_{\text{INB}}$. The total trace length to RSENSE should be minimized and the capacitors $C_{\text{SF}}$, $C_{\text{CAP}}$ and $C_{\text{INB}}$ should be placed near the $V_{\text{IN}}$ pin of the LTC3863. $C_{\text{CAP}}$ should be placed near the $V_{\text{IN}}$ and CAP pins. Figure 9 shows $C_{\text{CAP}}$ placed adjacent to the $V_{\text{IN}}$ and CAP pins with...
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SENSE routed between the pads. This is the recommended layout and results in the minimum parasitic inductance. The gate driver is capable of providing high peak current. Parasitic inductance in the gate drive and the series inductance between $V_{IN}$ to $CAP$ can cause a voltage spike between $V_{IN}$ and $CAP$ on each switching cycle. The voltage spike can result in electrical over-stress to the gate driver and can result in gate driver failures in extreme cases. It is recommended to follow the example shown in Figure 9 for the placement of $C_{CAP}$ as close as is practical.

$R_{GATE}$ resistor pads can be added with a 0Ω resistor to allow the damping resistor to be added later. The total length of the gate drive trace to the PMOS gate should be minimized and ideally be less than 1cm. In most cases with a good layout the $R_{GATE}$ resistor is not needed. The $R_{GATE}$ resistor should be located near the gate pin to reduce peak current through GATE and minimize reflected noise on the gate pin.

The $R_{SF}$ and $C_{SF}$ pads can be added with a zero ohm resistor for $R_{SF}$ and $C_{SF}$ not populated. In most applications, external filtering is not needed. The current sense filter $R_{SF}$ and $C_{SF}$ can be added later if noise if demonstrated to be a problem.

The bypass capacitor $C_{INB}$ is used to locally filter the $V_{IN}$ supply. $C_{INB}$ should be tied to the $V_{IN}$ pin trace and to the PGND exposed pad. The $C_{INB}$ positive pad should connect to $R_{SENSE}$ positive though the $V_{IN}$ pin trace. The $C_{INB}$ ground trace should connect to the PGND exposed pad connection.

PC Board Layout Checklist

When laying out the printed circuit board, the following checklist should be used to ensure proper operation of the LTC3863.

1. Multilayer boards with dedicated ground layers are preferable for reduced noise and for heat sinking purposes. Use wide rails and/or entire planes for $V_{IN}$, $V_{OUT}$ and GND for good filtering and minimal copper loss. If a ground layer is used, then it should be immediately below (and/or above) the routing layer for the power train components which consist of $C_{IN}$, sense resistor, P-channel MOSFET, Schottky diode, inductor, and $C_{OUT}$. Flood unused areas of all layers with copper for better heat sinking.

2. Keep signal and power grounds separate except at the point where they are shorted together. Short the signal and power ground together only at a single point with a narrow PCB trace (or single via in a multilayer board). All power train components should be referenced to power ground and all small-signal components (e.g., $C_{TH1}$, $R_{FREQ}$, $C_{SS}$ etc.) should be referenced to the signal ground.

3. Place $C_{IN}$, sense resistor, P-channel MOSFET, inductor, and primary $C_{OUT}$ capacitors close together in one compact area. The junction connecting the drain of the P-channel MOSFET, cathode of the Schottky, and (+) terminal of the inductor (this junction is commonly referred to as switch or phase node) should be compact but be large enough to handle the inductor currents without large copper losses. Place the sense resistor and source of P-channel MOSFET as close as possible to the (+) plate of the $C_{IN}$ capacitor(s) that provides the bulk of the AC current (these are normally the ceramic capacitors), and connect the (–) terminal of the inductor as close as possible to the (–) terminal of the same $C_{IN}$ capacitor(s). The high $dI/dt$ loop formed by $C_{IN}$, the MOSFET, and the Schottky diode should have short leads and PCB trace lengths to minimize high frequency EMI and voltage stress from inductive ringing. The (+) terminal of the primary $C_{OUT}$ capacitor(s) which filter the bulk of the inductor ripple current (these are normally the ceramic capacitors) should also be connected close to the (–) terminal of $C_{IN}$.

4. Place Pins 7 to 12 facing the power train components. Keep high $dV/dt$ signals on GATE and switch away from sensitive small-signal traces and components.

5. Place the sense resistor close to the (+) terminal of $C_{IN}$ and source of P-channel MOSFET. Use a Kelvin (4-wire) connection across the sense resistor and route the traces together as a differential pair into the $V_{IN}$ and SENSE pins. An optional RC filter could be placed near the $V_{IN}$ and SENSE pins to filter the current sense signal.
6. Place the resistive feedback divider $R_{FB1/2}$ as close as possible to the $V_{FB}$ and $V_{FBN}$ pins. The (–) terminal of the feedback divider should connect to the output regulation point and the (+) terminal of the feedback divider should connect to $V_{FB}$.

7. Place the ceramic $C_{CAP}$ capacitor as close as possible to the $V_{IN}$ and CAP pins. This capacitor provides the gate discharging current for the power P-channel MOSFET.

8. Place small signal components as close to their respective pins as possible. This minimizes the possibility of PCB noise coupling into these pins. Give priority to $V_{FB}$, ITH, and FREQ pins. Use sufficient isolation when routing a clock signal into the PLLIN /MODE pin so that the clock does not couple into sensitive small-signal pins.

**Failure Mode and Effects Analysis (FMEA)**

A FMEA study on the LTC3863 has been conducted through adjacent pin opens and shorts. The device was tested in a step-down application (Figure 15) from $V_{IN} = 12V$ to $V_{OUT} = -5V$ with a current load of 2A on the output. One group of tests involved the application being monitored while each pin was disconnected from the PC board and left open while all other pins remained intact. The other group of tests involved each pin being shorted to its adjacent pins while all other pins were connected as it would be normally in the application. The results are shown in Table 2.

For FMEA compliance, the following design implementations are recommended:

- If the RUN pin is being pulled up to a voltage greater than 6V, then it is done so through a pull-up resistor (100k to 1M) so that the $V_{FBN}$ pin is not damaged in case of a RUN to $V_{FBN}$ short.

- The gate of the external P-channel MOSFET should be pulled through a resistor (20k to 100k) to the input supply, $V_{IN}$ so that the P-channel MOSFET is guaranteed to turn off in case of a GATE open.

- To protect against the $V_{FBN}$ open condition it is necessary to add an output shutdown clamp. The output shutdown clamp is comprised of a Zener, $V_{Z}$, NPN and Zener bias resistor, $R_{Z}$, to ground as found in Figure 10. The clamp voltage will be the Zener forward voltage $V_{Z}$ plus a $V_{BE}$. The clamp needs to be designed such that the worst-case minimum Zener voltage is less than the maximum operating voltage. The worst-case Zener leakage current times the Zener bias resistor should not exceed 200mV.

![Figure 10.](image-url)
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### Table 2

<table>
<thead>
<tr>
<th>FAILURE MODE</th>
<th>$V_{OUT}$</th>
<th>$I_{OUT}$</th>
<th>$I_{VIN}$</th>
<th>$f$</th>
<th>RECOVERY WHEN FAULT IS REMOVED?</th>
<th>BEHAVIOR</th>
</tr>
</thead>
<tbody>
<tr>
<td>None</td>
<td>–5V</td>
<td>1A</td>
<td>453mA</td>
<td>350kHz</td>
<td>N/A</td>
<td>Normal Operation.</td>
</tr>
<tr>
<td><strong>Pin Open</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Open Pin 1 (PLLIN/MODE)</td>
<td>–5V</td>
<td>1A</td>
<td>453mA</td>
<td>350kHz</td>
<td>OK</td>
<td>Pin already left open in normal application, so no difference.</td>
</tr>
<tr>
<td>Open Pin 2 (FREQ)</td>
<td>–5V</td>
<td>1A</td>
<td>453mA</td>
<td>535kHz</td>
<td>OK</td>
<td>Frequency jumps to default open value.</td>
</tr>
<tr>
<td>Open Pin 3 (GND)</td>
<td>–5V</td>
<td>1A</td>
<td>453mA</td>
<td>350kHz</td>
<td>OK</td>
<td>Exposed pad still provides GND connection to device.</td>
</tr>
<tr>
<td>Open Pin 4 (SS)</td>
<td>–5V</td>
<td>1A</td>
<td>453mA</td>
<td>350kHz</td>
<td>OK</td>
<td>External soft-start removed, but internal soft-start still available.</td>
</tr>
<tr>
<td>Open Pin 5 ($V_{FE}$)</td>
<td>0V</td>
<td>0A</td>
<td>0.7mA</td>
<td>0kHz</td>
<td>OK</td>
<td>Controller stops switching. $V_{FB}$ internally self bias HI to prevent switching.</td>
</tr>
<tr>
<td>Open Pin 6 (ITH)</td>
<td>–5V</td>
<td>1A</td>
<td>507mA</td>
<td>40kHz</td>
<td>OK</td>
<td>Output still regulating, but the switching is erratic. Loop not stable.</td>
</tr>
<tr>
<td>Open Pin 7 ($V_{FBN}$)</td>
<td>–6V pk</td>
<td>1A</td>
<td>502mA</td>
<td>350kHz</td>
<td>OK</td>
<td>Use a 5.1V Zener $V_{Z}$, 10k $R_{Z}$ and 0.01µF $C_{Z}$. Output Voltage is –6V peak and averages –4.9V.</td>
</tr>
<tr>
<td>Open Pin 8 (RUN)</td>
<td>–5V</td>
<td>1A</td>
<td>453mA</td>
<td>350kHz</td>
<td>OK</td>
<td>Controller does not start-up.</td>
</tr>
<tr>
<td>Open Pin 9 (CAP)</td>
<td>–5V</td>
<td>1A</td>
<td>453mA</td>
<td>350kHz</td>
<td>OK</td>
<td>More jitter during switching, but regulates normally.</td>
</tr>
<tr>
<td>Open Pin 10 (SENSE)</td>
<td>0V</td>
<td>0A</td>
<td>0.7mA</td>
<td>0kHz</td>
<td>OK</td>
<td>$V_{IN}$ able to bias internally through SENSE. Regulates with high $V_{OUT}$ ripple.</td>
</tr>
<tr>
<td>Open Pin 11 ($V_{IN}$)</td>
<td>–5.4V</td>
<td>1A</td>
<td>597mA</td>
<td>20kHz</td>
<td>OK</td>
<td>Gate does not drive external power FET, preventing output regulation.</td>
</tr>
<tr>
<td>Open Pin 12 (GATE)</td>
<td>0V</td>
<td>0A</td>
<td>0.7mA</td>
<td>0kHz</td>
<td>OK</td>
<td>Pin 3 (GND) still provides GND connection to device.</td>
</tr>
</tbody>
</table>

### Pins Shorted

| Short Pins 1, 2 (PLLIN/MODE and FREQ) | –5V | 1A | 453mA | 350kHz | OK | Burst Mode operation disabled, but runs normally as in pulse-skipping mode. |
| Short Pins 2, 3 (FREQ and GND) | –5V | 1A | 453mA | 0kHz | OK | FREQ already shorted to GND, so regulates normally. |
| Short Pins 3, 4 (GND and SS) | 0V | 0A | 0.7mA | 0kHz | OK | SS short to GND prevents device from starting up. |
| Short Pins 4, 5 (SS and $V_{FB}$) | –1V(DC) –$3V_{P-P}$ | 50mA | 9mA | Erratic | OK | $V_{OUT}$ oscillates from 0V to 3V. |
| Short Pins 5, 6 ($V_{FB}$ and ITH) | –3.15V | 625mA | 181mA | 350kHz | OK | Controller loop does not regulate to proper output voltage. |
| Short Pins 7, 8 ($V_{FBN}$ and RUN) | 5V | 0A | 860µA | 350kHz | OK | Controller does not start-up. |
| Short Pins 8, 9 (RUN and CAP) | –5V | 1A | 453mA | 350kHz | OK | Able to start-up and regulate normally. |
| Short Pins 9, 10 (CAP and SENSE) | 0V | 0A | 181mA | 0kHz | OK | $CAP \sim V_{IN}$, which prevents turning on external P-MOSFET. |
| Short Pins 10, 11 (SENSE and $V_{IN}$) | –5V | 1A | 453mA | 50kHz | OK | Regulates with high $V_{OUT}$ ripple. |
| Short Pins 11, 12 ($V_{IN}$ and GATE) | 0V | 0A | 29mA | 0kHz | OK | Power MOSFET is always kept OFF, preventing regulation. |
TYPICAL APPLICATIONS

Figure 11. Design Example, 4.5V to 55V Input, ±5V, 1.8A at 320kHz

Gain/Phase Measurements Taken with OMICRON Lab Bode 100 Vector Network Analyzer.
Figure 12. 5V to 23V Input, –18V/700mA Output, 750kHz Inverting Converter

Gain/Phase Measurements Taken with OMICRON Lab Bode 100 Vector Network Analyzer.
For more information www.analog.com
TYPICAL APPLICATIONS

Figure 14. 12V to 42V Input, –48V/300mA Output, 440kHz Inverting Converter

Gain/Phase Measurements Taken with OMICRON Lab Bode 100 Vector Network Analyzer.
Figure 15. 4.5V to 16V Input, –5V/1.7A, –12V/1A Output, 350kHz Inverting Converter
DE/UE Package
12-Lead Plastic DFN (4mm × 3mm)
(Reference LTC DWG # 05-08-1695 Rev D)

NOTE:
1. DRAWING PROPOSED TO BE A VARIATION OF VERSION (WG35) IN JEDEC PACKAGE OUTLINE M0-229
2. DRAWING NOT TO SCALE
3. ALL DIMENSIONS ARE IN MILLIMETERS
4. DIMENSIONS OF EXPOSED PAD ON BOTTOM OF PACKAGE DO NOT INCLUDE MOLD FLASH. MOLD FLASH, IF PRESENT, SHALL NOT EXCEED 0.15mm ON ANY SIDE
5. EXPOSED PAD SHALL BE SOLDER PLATED
6. SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE

For more information www.analog.com
PACKAGE DESCRIPTION

MSE Package
12-Lead Plastic MSOP, Exposed Die Pad
(Reference LTC DWG # 05-08-1666 Rev F)

NOTE:
1. DIMENSIONS IN MILLIMETER/(INCH)
2. DRAWING NOT TO SCALE
3. DIMENSION DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
   MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.152mm (.006") PER SIDE
4. DIMENSION DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSIONS.
   INTERLEAD FLASH OR PROTRUSIONS SHALL NOT EXCEED 0.152mm (.006") PER SIDE
5. LEAD COPLANARITY (BOTTOM OF LEADS AFTER FORMING) SHALL BE 0.102mm (.004") MAX
6. EXPOSED PAD DIMENSION DOES INCLUDE MOLD FLASH. MOLD FLASH ON E-PAD SHALL
   NOT EXCEED 0.254mm (.010") PER SIDE.
## REVISION HISTORY

<table>
<thead>
<tr>
<th>REV</th>
<th>DATE</th>
<th>DESCRIPTION</th>
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</table>
| A   | 6/14 | PLL/MODE, VFNB and ITH Pin Descriptions Updated  
Added Paragraph Discussing RFB2 Sizing and Equation  
Updated $V_{\text{OUT}}$ and $\Delta I_L$ Equations  
Updated $I_{\text{OUT(CDB)}}$, $I_{\text{L(PEAK_MAX)}}$ and $R_{\text{SENSE}}$ Equations | 8  
13  
23  
24 |
| B   | 7/19 | Fixed $I_L$ Formula | 24 |

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TYPICAL APPLICATION

Gain/Phase Measurements Taken with OMICRON Lab Bode 100 Vector Network Analyzer.

RELATED PARTS

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<tr>
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<th>DESCRIPTION</th>
<th>COMMENTS</th>
</tr>
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<tr>
<td>LTC3864</td>
<td>Low IQ, High Voltage Step-Down DC/DC Controller with 100% Duty Cycle</td>
<td>Fixed Frequency 50kHz to 850kHz, 3.5V ≤ V_{IN} ≤ 60V, 0.8V ≤ V_{OUT} ≤ V_{IN}, ( I_O = 40\mu A ), MSOP-12E, 3mm × 4mm DFN-12</td>
</tr>
<tr>
<td>LTC3891</td>
<td>60V, Low IQ, Synchronous Step-Down DC/DC Controller</td>
<td>PLL Fixed Frequency 50kHz to 900kHz, 4V ≤ V_{IN} ≤ 60V, 0.8V ≤ V_{OUT} ≤ 24V, ( I_O = 50\mu A )</td>
</tr>
<tr>
<td>LTC3890/LTC3890-1</td>
<td>60V, Low IQ, Dual 2-Phase Synchronous Step-Down DC/DC Controller</td>
<td>PLL Fixed Frequency 50kHz to 900kHz, 4V ≤ V_{IN} ≤ 60V, 0.8V ≤ V_{OUT} ≤ 24V, ( I_O = 50\mu A )</td>
</tr>
<tr>
<td>LTC3630</td>
<td>High Efficiency, 65V, 500mA Synchronous Step-Down Regulator</td>
<td>4V ≤ V_{IN} ≤ 65V, 0.8V ≤ V_{OUT} ≤ V_{IN}, ( I_O = 12\mu A ), 3mm × 5mm DFN-16 and MSOP-16E</td>
</tr>
<tr>
<td>LTC3834/LTC3834-1</td>
<td>Low IQ, Single Output Synchronous Step-Down DC Controllers with 99% Duty Cycle</td>
<td>PLL Fixed Frequency 140kHz to 650kHz, 4V ≤ V_{IN} ≤ 36V, 0.8V ≤ V_{OUT} ≤ 10V, ( I_O = 30\mu A/20\mu A )</td>
</tr>
<tr>
<td>LT3758A</td>
<td>High Input Voltage, Boost, Flyback, SEPIC and Inverting Controller</td>
<td>5.5V ≤ V_{IN} ≤ 100V, Positive or Negative V_{OUT}, 3mm × 3mm DFN-10 and MSOP-10E</td>
</tr>
<tr>
<td>LTC3826/LTC3826-1</td>
<td>Low IQ, Dual Output 2-Phase Synchronous Step-Down DC Controllers with 99% Duty Cycle</td>
<td>PLL Fixed Frequency 50kHz to 900kHz, 4V ≤ V_{IN} ≤ 36V, 0.8V ≤ V_{OUT} ≤ 10V, ( I_O = 30\mu A )</td>
</tr>
<tr>
<td>LTC3859AL</td>
<td>Low IQ, Triple Output Buck/Buck/Boost Synchronous DC/DC Controller</td>
<td>All Outputs Remain in Regulation Through Cold Crank 2.5V ≤ V_{IN} ≤ 38V, ( V_{OUT(BUCKS)} ≤ 24V ), ( V_{OUT(BOOST)} ≤ 60V ), ( I_O = 28\mu A )</td>
</tr>
</tbody>
</table>